

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
243266US3 CONTSERIAL NO.  
New Continuation Appln.

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT  
Kiyotaka INOUE, et al.FILING DATE  
Herewith

GROUP

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	5,482,161	1/9/96 <sup>1996</sup>	Williams, et al.			
	AB	4,724,874	2/16/88 <sup>1988</sup>	Parikh, et al.			
	AC	4,995,430	2/26/91 <sup>1991</sup>	Bonora, et al.			
	AD	5,137,063	8/11/92 <sup>1992</sup>	Foster, et al.			
	AE	5,217,053	6/8/93 <sup>1993</sup>	Foster, et al.			
	AF	5,273,423	12/28/93 <sup>1993</sup>	Shiraiwa			
	AG	5,291,923	3/8/94 <sup>1994</sup>	Gallagher, et al.			
	AH	5,295,522	3/22/94 <sup>1994</sup>	DeAngelis, et al.			
	AI	5,320,218	6/14/94 <sup>1994</sup>	Yamashita, et al.			
	AJ	5,378,283	1/3/95 <sup>1995</sup>	Ushikawa			
	AK	5,433,574	7/18/95 <sup>1995</sup>	Kawano, et al.			
	AL	5,697,750	12/16/97 <sup>1997</sup>	Fishkin, et al.			
	AM	5,713,711	2/3/98 <sup>1998</sup>	McKenna, et al.			
	AN	6,123,120	12/26/00 <sup>2000</sup>	Yotsumoto, et al.			

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO	7-315477	12/5/95	Japan (w/ Corresponding U.S. 5,482,161)		X
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW		
	AX		
	AY		
	AZ		
Examiner <i>John R. Wells</i>			<input type="checkbox"/> Additional References sheet(s) attached
			Date Considered <i>4/5/04</i>

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

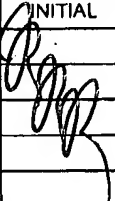
Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
243266US3 CONTSERIAL NO.  
New Continuation Appln.

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT  
Kiyotaka INOUE, et al.FILING DATE  
Herewith

GROUP

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	BA	6,135,168	10/24/00	Yang, et al.			
	BB	6,261,044	7/17/01	Fosnight, et al.			
	BC	6,302,927	10/16/01	Tanigawa			
	BD						
	BE						
	BF						
	BG						
	BH						
	BII						
	BJ						
	BK						
	BL						
	BM						
	BN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	BO					
	BP					
	BQ					
	BR					
	BS					
	BT					
	BU					
	BV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	BW	
	BX	
	BY	
	BZ	

☐ Additional References sheet(s) attached

Examiner

Date Considered

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.